Application/Control No. Applicant(s)/Patent Under Reexamination 10/791,573 KIM ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2629 Jean E. Lesperance **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 345/616 US-6,556,214 B1 04-2003 Yamada et al. Α В US-US-С US-D US-Е US-F US-G US-Н US-1 US-J Κ US-US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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